S	earch Notes	
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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/823,410	CHIN, HON WAH	•
Examiner	Art Unit	
YOUNG T. TSE	2637	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	225, 238- 239, 282, 333	7/7/2005	٧٢
375	360-361	1	
370	212-213		
370	232-234		
329	312, 313		
329	314		
332	109-114		
341	61, 68-70		
Updated	Search	1/22/06	7
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TAI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
375	225,238	1/22/06	21
370	212	1	1
329	312		
341	61	1	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST and inventors Name Search	7/7/2005	YT
EAST Search	11/7/05	7
Applated EAST Search	1/22/06	7
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